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**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

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**Complete if Known**

Application Number	09/479,262
Filing Date	January 5, 2000
First Named Inventor	Shunpei Yamazaki
Art Unit	2815
Examiner Name	E. Wojciechowicz
Attorney Docket Number	SEL 154

Sheet 1 of 1

**OTHER PRIOR ART-NON PATENT LITERATURE DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
EW	1	Office Action mailed on February 25, 2003 of U.S. Patent Application Serial No. 09/472,079, which is a related application of the present application.	

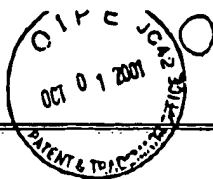
Examiner Signature		Date Considered	5-20-04
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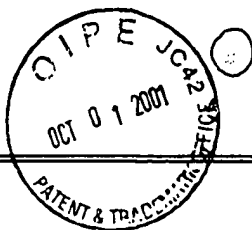
<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.

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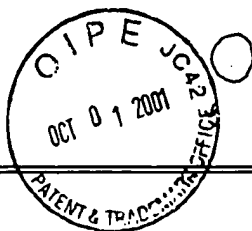
LIST OF PUBLICATIONS CITED BY APPLICANT			Attorney Docket No. SEL 154		Serial No. 09/479,262	
			Applicant Shunpei YAMAZAKI			
			Filing Date January 5, 2000		Group	
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	6,194,254	02/27/01	Takemura			03/28/97
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
EA	JP 05-152328	06/18/93	Hiroshi			11/28/91
	JP 07-130652	05/19/95	Otani et al.			10/29/93
	JP 07-278790	10/24/95	Satoru			02/21/95
	JP 08-078329	03/22/96	Otani			09/05/94
	JP 08-254713	10/01/96	Fukuda			03/16/95
	JP 08-330602	12/13/96	Tanaka et al.			03/27/96
EA	JP 10-092576	04/10/98	Friend et al.			04/18/97
OTHER PUBLICATIONS (Including Author, Title, Date, Pertinent Pages)						
EA	8) JP 05-152328 English abstract. 9) JP 07-130652 English abstract. 10) JP 07-278790 English abstract. 11) JP 08-078329 English abstract. 12) JP 08-254713 English abstract. 13) JP 08-330602 English abstract. 14) JP 10-092576 English abstract.					
EA						
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U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
EJ	5,536,360	07/16/96	Nguyen et al.			01/03/95
	5,643,826	07/01/97	Ohtani et al.			10/25/94
	5,756,250	05/26/98	Hirai et al.			06/07/95
	5,923,962	07/13/99	Ohtani et al.			04/28/95
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	JP 63-120429	05/24/88	Katsuya			11/10/86
	JP 02-179947	07/12/90	Yujiro			01/04/89
	JP 02-234438	09/17/90	Naohiro			03/08/89
	JP 03-097846	04/23/91	Katsunori			09/07/89
	JP 04-367277	12/18/92	Osamu			06/14/91
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EJ	3) JP 63-120429 English abstract. 4) JP 02-179947 English abstract. 5) JP 02-234438 English abstract. 6) JP 03-097846 English abstract. 7) JP 04-367277 English abstract.					
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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
EJ	4,990,365	02/05/91	Treichel et al.			06/16/89
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	EP 0 999 595	05/10/00	Yamazaki et al.			11/02/99
	JP 62-156822	07/11/87	Takahiro			12/27/85
	JP 63-111173	05/16/88	Mikio			10/30/86
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81	JP 10-135468	05/22/98	Yamazaki et al.			10/24/96
	JP 10-135469	05/22/98	Yamazaki et al.			10/24/96
	JP 10-270363	10/09/98	Onuma et al.			03/27/97
	WO 90/13148	11/01/90	Friend et al.			04/18/90
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81	15) JP 10-135468 English abstract. 16) JP 10-135469 English abstract. 17) JP 10-270363 English abstract. 18) European Search Report re application no. EP 99 12 5839, dated 04/06/00. 19) European Search Report re application no. EP 99 12 5839, dated 12/07/00. 20) Maeda et al., "A Low-Permittivity Interconnection Using An SiBN Interlayer," <u>IEEE Transactions On Electron Devices</u> , Vol. 36, No. 9, pp. 1610-1614, September 1989. 21) Schenk et al., "Polymers For Light Emitting Diodes," <u>EuroDisplay '99</u> , Berlin, Germany, Septmber 6-9, 1999, pp. 33-37. 22) US Patent Application No. 09/472,079 (pending) to Yamazaki et al., including specification, claims, abstract, drawings and PTO filing receipt.					
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81			<del>8-4-03</del> 8-4-03			
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			<u>Applicant</u> Shunpei YAMAZAKI		JCS80 U.S. PTO 09/479252  01/05/00	
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	JP 10-135469	05/22/98	Semiconductor Energy Laboratory Co., Ltd.			10/24/96
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	2) English abstract re Japanese patent application no. 8-078329					
	3) English abstract re Japanese patent application no. 8-330602					
	4) English abstract re Japanese patent application no. 10-135468					
	5) English abstract re Japanese patent application no. 10-135469					
	6) English abstract re Japanese patent application no. 10-270363					

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